# **SPECIFICATION**

SPEC. No. 13a D A T E : 2013 Feb.

То

# **Non-Controlled Copy**

CUSTOMER'S PRODUCT NAME	TDK PRODUCT NAME
	MULTILAYER CERAMIC CHIP CAPACITORS
	C Series / Commercial Grade
	General (Up to 50V)
	Mid voltage (100 to 630V)
Discourse the second structure to TDK second	

Please return this specification to TDK representatives.

If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

# **RECEIPT CONFIRMATION**

DATE:	YEAR	MONTH	DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group TDK-EPC Corporation Engineering Ceramic Capacitors Business Group

APPROVED	Person in charge	APPROVED	CHECKED	Person in charge

#### 1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK-EPC Corporation Japan,

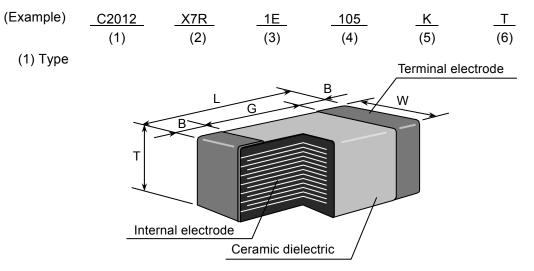
TDK (Suzhou) Co., Ltd and TDK Components U.S.A. Inc.

#### EXPLANATORY NOTE:

This specification warrants the quality of the ceramic chip capacitors. The chips should be evaluated or confirmed a state of mounted on your product.

If the use of the chips goes beyond the bounds of the specification, we can not afford to guarantee.

#### 2. CODE CONSTRUCTION



Please refer to product list for the dimension of each product.

- (2) Temperature Characteristics (Details are shown in table 1 No.7 and No.8 at page 5)
- (3) Rated Voltage

	1	
Symbol	Rated Voltage	
2 J	DC 630 V	
2 W	DC 450 V	
2 V	DC 350 V	
2 E	DC 250 V	
2 A	DC 100 V	
1 H	DC 50 V	
1 V	DC 35 V	
1 E	DC 25 V	
1 C	DC 16 V	
1 A	DC 10 V	
0 J	DC 6.3 V	
0 G	DC 4 V	



(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

Example 2R2  $\rightarrow$  2.2pF 105  $\rightarrow$  1,000,000pF

(5) Capacitance tolerance

Symbol	Tolerance	Capacitance
В	± 0.1 pF	
С	± 0.25 pF	10pF and under
D	± 0.5 pF	
J	± 5%	
К	± 10 %	Over 10pF
М	± 20 %	

(6) Packaging

Symbol	Packaging
В	Bulk
Т	Taping



#### 3. RATED CAPACITANCE AND CAPACITANCE TOLERANCE

Class	Temperature Characteristics	Capacitance tolerance		Rated capacitance
		10pF and	B (±0.1 pF) C (±0.25pF)	0.5, 1, 1.5, 2, 2.2, 3, 3.3, 4, 4.7, 5
1	СН	under	D (±0.5pF)	6, 6.8, 7, 8, 9, 10
I	C0G	12pF to 10,000pF	J (± 5 %)	E – 12 series
		Over 10,000pF	K (± 10 %)	E – 6 series
	J B X5R X6S	10uF and under	K (± 10 %) M (± 20 %)	
2	Z X7R	Over 10uF	M (± 20 %)	E – 6 series

#### 3.1 Standard combination of rated capacitance and tolerances

#### 3.2 Capacitance Step in E series

E series		Capacitance Step										
E- 3	1.0			2.2			4.7					
E- 6	1	.0	1	.5	2	.2	3	.3	4	.7	6	.8
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

#### 4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
C H J B	-25°C	85°C	20°C
X5R	-55°C	85°C	25°C
X6S	-55°C	105°C	25°C
X7R X7S X7T C0G	-55°C	125°C	25°C

#### 5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH 6 months Max.

#### 6. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as C3225, C4532 and C5750 types are more likely to be affected by heat stress from the substrate.

Please inquire separate specification for the large case sizes when mounted on the substrate.

#### 7. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.



#### 8. PERFORMANCE

			table 1				
No.	Item	Perform		Test or insp	ection meth	nod	
1	External Appearance	No defects which performance.	may affect		2 and C0603		3×), in case magnifying
2	Insulation Resistance	$10,000M\Omega$ or $500M$ (As for the capacito voltage 16, 10V DO $10,000 M\Omega$ or 1000 whichever smaller.	ors of rated C and lower, MΩ·μF min.,)	Apply rat	ted voltage f	for 60s.	
3	Voltage Proof	Withstand test volt	age without				
		insulation breakdov	wn or other	Class	Rated volta	ige Appl	y voltage
		damage.		Class1	100V and un		ted voltage
					Over 100		ated voltage
				Class2	100V and un		ated voltage
				Abovo D	Over 100\ C voltage sl	_	ated voltage
				1 to 5s.	discharge d		
4	Capacitance	Within the specifie	d tolerance.			1	-
				Class	Rated Capacitance	Measuring frequency	Measuring voltage
					1000pF and	1MHz±10%	
				Class1	under Over 1000pF	1kHz±10%	0.5-5 Vims.
					•	1111211070	0.5±0.2Vms.
				Class2	10uF and under	1kHz±10%	1.0±0.2Vms.
				CidSSZ		4001 - 1000/	
					Over 10uF	120Hz±20%	0.5±0.2Vms.
				measurir	mation whic ng voltage, p presentative	olease cont	as which act with our
5	Q	Pated Canacitance	Q		4 in this tabl	e for meas	uring
	(Class1)	Rated Capacitance 30pF and over	1,000 min.	condition	1.		
		Under 30pF	400+20×C min.				
		C : Rated capacita					
6	Dissipation Factor			See No.4	4 in this tabl	e for measi	uring
	(Class2)	T.C.	D.F.	condition			J
		J B X5R X6S X7R X7S X7S X7T	Dissipati	mation whic on Factor, p presentative	lease conta		





No.	Item	Performance	Test or inspection method
7	Temperature Characteristics of Capacitance (Class1)	T.C.Temperature Coeffici (ppm/°C)C H $0 \pm 60$ COG $0 \pm 30$ Capacitance driftWithin $\pm 0.2\%$ or $\pm 0.05$ pF, whichever larger.	Image: Performed and the second calculated based on values at 25°C and 85°C temperature.         Image: Performed and the second calculated based on values at 25°C and 85°C temperature.         Image: Performed and the second calculated based on values at 25°C and 85°C temperature.         Image: Performed and the second calculated based on values at 25°C and 85°C temperature.         Image: Performed and the second calculated based on values at 25°C and 85°C temperature.         Image: Performed and the second calculated based on values at 25°C and 10°C and -25°C.
8	Temperature Characteristics of Capacitance (Class2) Robustness of Terminations	Capacitance Change (%         No voltage applied       With voltag applied         J B : ±10       J B : ±10         J B : ±10       J B : ±10         S : ±10       J B : ±10         X5R : ±15         X6S : ±22         X7R : ±15         X7S : ±22         X7T : ±22         -33	ge       steps shown in the following table after thermal equilibrium is obtained for each step.         ΔC be calculated ref. STEP3 reading         ΔC be calculated ref. STEP3 reading         Step       Temperature(°C)         1       Reference temp. ± 2         2       Min. operating temp. ± 2         3       Reference temp. ± 2         4       Max. operating temp. ± 2         4       Max. operating temp. ± 2         Measuring voltage: 0.1, 0.2, 0.5, 1.0Vrms.         For information which product has which applied voltage, please contact with our sales representative.         g off,       Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b and apply a pushing force of 2N (C0603, C1005) or 5N (C1608, C2012, C3216, C3225, C4532, C5750) with 10±1s.         (Not applicable to C0402.)       Pushing force P.C.Board
10	Bending	No mechanical damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 2a or Appendix 2b and bend it for 1mm.



No.	Item	Performance	Test or inspection method
11	Solderability	(C0402)	Completely soak both terminations in
		Both end faces and the contact areas	solder at $235\pm5^{\circ}$ C for 2 $\pm$ 0.5s.
		shall be covered with a smooth and	
		bright solder coating with no more than	Solder : H63A (JIS Z 3282)
		a small amount of scattered	
		imperfections such as pinholes or	Flux: Isopropyl alcohol (JIS K 8839)
		un-wetted or de-wetted areas.	Rosin (JIS K 5902) 25% solid
		These imperfections shall not be	solution.
		concentrated in one area.	
		(Others)	Only reflow soldering applicable to
		New solder to cover over 75% of termination.	C0402.
		25% may have pin holes or rough spots	Peak condition
		but not concentrated in one spot.	Temp. : 235±5°C
		Ceramic surface of A sections shall not	Time: 2±0.5s.
		be exposed due to melting or shifting of	Preheating condition
		termination material.	Temp. : 150±10°C
			Time: 1 to 2min.
		A section	



No.	lte	em		Perfo	ormance	Test or inspection method	
12	Resistance to solder heat	External appearance	terminati	ons sha	llowed and all be covered at new solder.	Completely soak both terminations in solder at 260±5°C for 5±1s.	
		Capacitance				Preheating condition Temp. : 150±10°C	
			Charact	teristics	Change from the value before test	Time: 1 to 2min.	
				Class 1	C H C0G	Capacitance drift within ±2.5% or ±0.25pF, whichever larger.	Solder : H63A (JIS Z 3282)
			Class 2	J B X5R X6S X7R X7R X7S X7T	$\pm 7.5 \%$ $\pm 7.5 \%$ $\pm 7.5 \%$ $\pm 7.5 \%$ $\pm 7.5 \%$ $\pm 7.5 \%$ $\pm 7.5 \%$	Flux : Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.	
					11.5 /0	Leave the capacitors in ambient	
		Q (Class1)				<ul> <li>condition for 6 to 24h (Class1) or 24±2h</li> <li>(Class2) before measurement.</li> </ul>	
				apacitance		(Glassz) before measurement.	
			· · · ·	and over	1,000 min.	Only reflow soldering applicable to	
				er 30pF	400+20×C min.	C0402.	
			C : Rated capacitance (pF)			Peak condition	
		D.F.	Meet the	initial s	spec.	Temp. : 235±5°C	
		(Class2)				Time: 2±0.5s.	
		Insulation	Meet the initial spec. No insulation breakdown or other damage.			Preheating condition	
		Resistance				Temp. : 150±10°C Time : 1 to 2min.	
		Voltage proof					
13	Vibration	External appearance	No mech	No mechanical damage.		Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or	
		Capacitance				Appendix 1b before testing.	
			Charact		Change from the value before test	Vibrate the capacitors with amplitude	
			Class1	CH C0G	±2.5% or ±0.25pF, whichever larger.	of 1.5mm P-P changing the	
			Class2	J B X5R X6S X7R X7R X7S X7T	± 7.5 % ± 7.5 % ± 7.5 % ± 7.5 % ± 7.5 % ± 7.5 %	frequencies from 10Hz to 55Hz and back to 10Hz in about 1min. Repeat this for 2h each in 3 perpendicular directions.	
		Q				_	
		(Class1)	Rated C	Capacitanc	xe Q		
			30pF	and over	1,000 min.		
			Und	er 30pF	400+20×C min.		
			C : Rateo	d capac	itance (pF)		
		D.F. (Class2)	Meet the	initial s	spec.		





No.	lte	em		Perfo	rmance		Test or inspection m	nethod	
14	Temperature cycle	External appearance	No mecha	No mechanical damage.			Reflow solder the capacitors on a P.C.Board shown in Appendix1a or		
		Class1 COC J B X5F *Class2 X7F		C H COG J B X5R X6S X7R X7S	Change from the value before test $\pm 2.5\%$ or $\pm 0.25pF$ , whichever larger. $\pm 7.5\%$ $\pm 10\%$ $\pm 12.5\%$	Appendix1b before testing. Expose the capacitors in the cond step1 through step 4 and repeat 9 consecutively. Leave the capacitors in ambient condition for 6 to 24h (Class 1) of 24±2h (Class 2) before measurer		epeat 5 times bient s 1) or	
			* Applied for some parts.			Step	Temperature(°C)	Time (min.)	
		Q (Class1)				1	Min. operating temp. ± 3	30 ± 3	
			(Classi) =	Rated Ca 30pF a	ndover	over 1,000 min.		Reference Temp.	2 - 5
				Under 30pF 400+20×C min. C : Rated capacitance (pF)		3	Max. operating temp. ± 2	30 ± 2	
		D.F. (Class2)	Meet the	initial s	pec.	4	Reference Temp.	2 - 5	
		Insulation Resistance	Meet the initial spec.						
		Voltage proof	No insulat damage.	tion bre	akdown or other				



No.	lte	em		Perfor	mance	Test or inspection method
15	Moisture Resistance	External appearance	No mecha	nical da	mage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or
	(Steady State)		Characte		Change from the value before test	Appendix 1b before testing. Leave at temperature 40 $\pm$ 2°C, 90 to
			Class1		±5% or ±0.5pF, whichever larger.	95%RH for 500 +24,0h.
			*Class2	J B X5R X6S X7R X7R X7S X7T	± 10 % ± 12.5 % ± 25 %	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24 ± 2h (Class2) before measurement.
			* Applied for some parts.			-
		Q (Class1)	Rated Capacitance Q			
			30pF a	nd over	350 min.	
				nd over `30pF	275+5/2×C min.	
			Under	Under 10pF 200+10×C min.		
			C : Rated	capacita	ance (pF)	
		D.F. (Class2)	200% of in	iitial spe	c. max.	
		Insulation	1,000MΩ o	r 50MΩ·μ	ıF min.	
		Resistance	(As for the	capacit	ors of rated	
			•	•	C and lower,	
			1,000 M $\Omega$ or 10M $\Omega$ ·µF min.,) whichever smaller.			



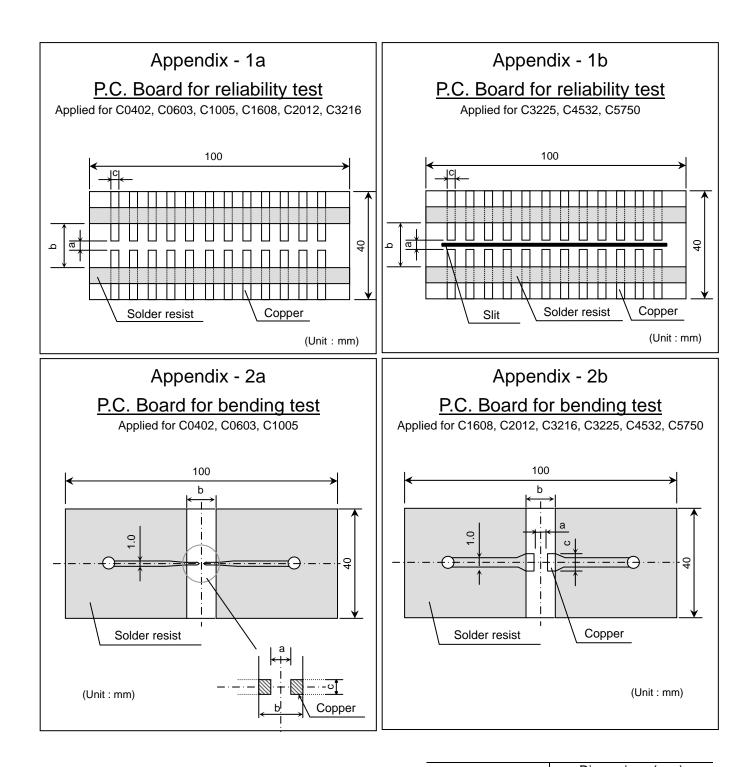
No.	lt	em		Perfor	rmance	Test or inspection method
16	Moisture Resistance	External appearance	No mechanical damage.			Reflow solder the capacitors on a P.C.Board shown in Appendix1a or Appendix 1b before testing.
		Capacitance Q (Class1)	Characte	Characteristics Change from the value before test		Apply the rated voltage at temperature 40±2°C and 90 to
			Class1	C H C0G	±7.5% or ±0.75pF, whichever larger.	95%RH for 500 +24,0h.
			_	J B X5R	± 10 %	Charge/discharge current shall not exceed 50mA.
			*Class2	X6S X7R	± 12.5 %	Leave the capacitors in ambient
				X7S X7T	Т	condition for 6 to 24h (Class1) or 24±2h (Class2) before measuremen
			* Applied for some parts.			
						Voltage conditioning (only for class 2 Voltage treat the capacitors under
			Rated Capacitand		ce Q	testing temperature and voltage for
			30pF a	ind over	200 min.	hour.
			Unde	r 30pF	100+10/3×C min.	Leave the capacitors in ambient
			C : Rated	capacit	ance (pF)	- condition for 24±2h before
		D.F.	200% of ir	nitial spe	ec. max.	measurement.
		(Class2)				Use this measurement for initial
		Insulation	500MΩ or	· 25MΩ·	µF min.	value.
		Resistance	(As for the	e capaci	tors of rated	
			-		C and lower, 500	
				Ω·µF m	in.,) whichever	
			smaller.			



No.		Item		Perfor	rmance	Test or inspection method	
17	Life	External appearance	No mecha	nical da	amage.	Reflow solder the capacitors on a P.C.Board shown in Appendix1a or Appendix 1b before testing.	
		Capacitance	Characte	eristics	Change from the value before test	Below the voltage shall be applied at maximum operating temperature ±2°	
			Class1	C H C0G	±3% or ±0.3pF, whichever larger.	for 1,000 +48, 0h.	
				JB		Applied voltage	
			*Class2	X5R X6S	± 10 % ± 12.5 % ± 25 %	Rated voltage x2	
			Classz	X7R X7S		Rated voltage x1.5	
				X7U X7T		Rated voltage x1.2	
			* Applied for some parts.			Rated voltage x1	
		Q				For information which product has	
		(Class1)	Rated Capacitance         Q           30pF and over         350 min.			which applied voltage, please contact	
				and over over unde	350 min.	with our sales representative.	
			30	ЭрF	275+5/2×C min.	Charge/discharge current shall not	
			Under 10pF200+10×C min.C : Rated capacitance (pF)			exceed 50mA. Leave the capacitors in ambient	
		D.F.	200% of ir	nitial spe	ec. max.	condition for 6 to 24h (Class1) or	
		(Class2)				24±2h (Class2) before measurement	
		Insulation	1,000MΩ o			Voltage conditioning (only for class 2	
		Resistance	•		tors of rated C and lower,	Voltage treat the capacitors under	
			•		$\Omega \cdot \mu F min.,)$	testing temperature and voltage for 1 hour.	
			whichever		• •	Leave the capacitors in ambient	
						condition for $24\pm 2h$ before	
						measurement.	
						Use this measurement for initial value	

\*As for the initial measurement of capacitors (Class2) on number 8,12,13,14 and 15, leave capacitors at 150  $-10,0^{\circ}$ C for 1 hour and measure the value after leaving capacitors for 24 ± 2h in ambient condition.





Material : Glass Epoxy ( As per JIS C6484 GE4 )

P.C. Board thickness : Appendix-2a 0.8mm

Copper (thickness 0.035mm)

Appendix-1a, 1b, 2b 1.6mm

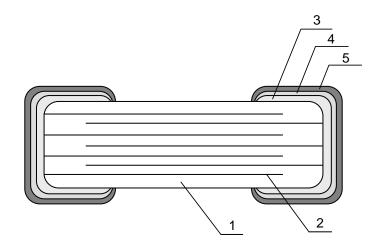
Solder resist

	Dime	ensions (n	nm)
TDK (EIA style)	а	b	С
C0402 (CC01005)	0.2	0.8	0.2
C0603 (CC0201)	0.3	0.8	0.3
C1005 (CC0402)	0.4	1.5	0.5
C1608 (CC0603)	1.0	3.0	1.2
C2012 (CC0805)	1.2	4.0	1.65
C3216 (CC1206)	2.2	5.0	2.0
C3225 (CC1210)	2.2	5.0	2.9
C4532 (CC1812)	3.5	7.0	3.7
C5750 (CC2220)	4.5	8.0	5.6





### 9. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL					
NO.	NAME	Class1	Class2				
1	Dielectric	CaZrO <sub>3</sub>	BaTiO₃				
2	Electrode	Nickel (Ni)					
3		Copper (Cu)					
4	Termination	Nicke	I (Ni)				
5		Tin (Sn)					

### **10. RECOMMENDATION**

As for C3225, C4532 and C5750 types, It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

### **11. SOLDERING CONDITION**

As for C0402, C0603, C1005, C3225, C4532 and C5750 types, reflow soldering only.



## 12. Caution

No.	Process	Condition
1	Operating Condition (Storage, Transportation)	<ol> <li>Storage         <ol> <li>The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt.</li> <li>The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur.</li> <li>Avoid storing in sun light and falling of dew.</li> <li>Do not use capacitors reliability.</li> <li>Capacitors should be tested for the solderability when they are stored for long time.</li> <li>Handling in transportation In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 Handling in transportation)</li> </ol> </li> </ol>
2	Circuit design ▲ Caution	<ul> <li>2-1. Operating temperature Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature.</li> <li>1) Do not use capacitors above the maximum allowable operating temperature.</li> <li>2) Surface temperature including self heating should be below maximum operating temperature.</li> <li>(Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C)</li> <li>3) The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature. The capacitors should be selected and designed in taking the temperature into consideration.</li> <li>2-2. Operating voltage across the terminals should be below the rated voltage.</li> <li>When AC and DC are super imposed, V<sub>0-P</sub> must be below the rated voltage.</li> <li>— (1) and (2) AC or pulse with overshooting, V<sub>P-P</sub> must be below the rated voltage.</li> <li>— (1) DC voltage (2) DC+AC voltage (3) AC voltage Irregular voltage.</li> <li>Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage</li> <li>Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)</li> <li>Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)</li> <li>Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)</li> <li>Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)</li> <li>Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)</li> </ul>



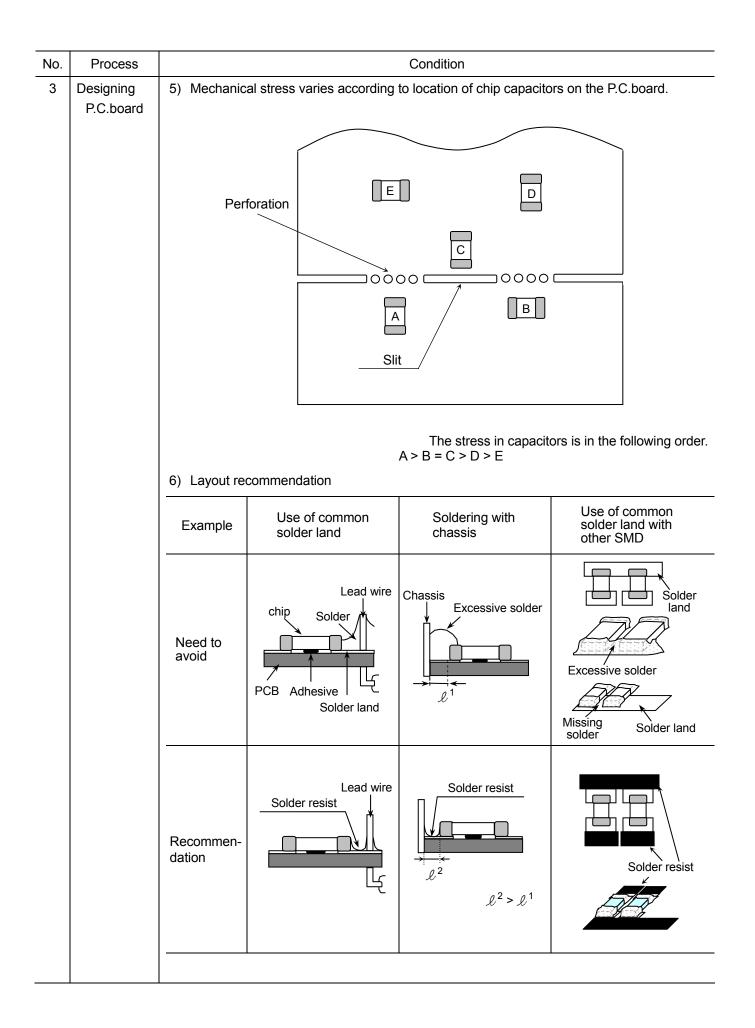


No.	Process				Cond	ition				
2	Circuit design <u>∧</u> Caution		he rated volta ne capacitors i				requend	cy AC or	pul	se is applied, the
		<ol> <li>The effective The capacitor consideration</li> </ol>	rs should be s		•	•				•
			apacitors (Clas nay vibrate the							s, the
3	Designing P.C.board			solder, /ill brea	the higl k. Whe	her the n desig	stress on ning a l	on the ch P.C.boar	nip c d, de	apacitors, etermine the
		<ol> <li>Avoid using common solder land for multiple terminations and provid solder land for each terminations.</li> </ol>							de individual	
		3) Size and reco	ommended lar	nd dime	ensions					
				Chip	capacit	ors S	older la	nd		
			¢					s s	— Solder resist	
		_, ,,	. <b>B</b>	→←	Α	<b>→</b>			,	
		Flow solder	т <b>о</b>	0		2012		C321	(mm	1)
		Symbol	(CC060			C0805	)	(CC120		
		A	0.7 - 1	.0	1.	.0 - 1.3		2.1 - 2	.5	
		B	0.8 - 1			.0 - 1.2		1.1 - 1		
		C	0.6 - 0	.8	0.	.8 - 1.1		1.0 - 1	.3	
		Reflow sold	lering							(mm)
		Type Symbol	C0402 (CC01005)		603 0201)		005 0402)	C160 (CC060		C2012 (CC0805)
		A	0.15 - 0.25	0.25	- 0.35	0.3	- 0.5	0.6 - 0	.8	0.9 - 1.2
		В	0.15 - 0.25		- 0.3		- 0.45	0.6 - 0		0.7 - 0.9
		C	0.15 - 0.25	0.25	- 0.35	0.4	- 0.6	0.6 - 0	.8	0.9 - 1.2
		Type Symbol	C3216 (CC1206)		C322 (CC12			532 1812)	(	C5750 (CC2220)
		A	2.0 - 2.4		2.0 - 2	2.4	3.1	- 3.7		4.1 - 4.8
		В	1.0 - 1.2		1.0 - 1	1.2	1.2	- 1.4		1.2 - 1.4
		С	1.1 - 1.6		1.9 - 2	2.5	2.4	- 3.2		4.0 - 5.0



No.	Process		Condition						
3	Designing P.C.board	4) Recommended	d chip capacitors layout is as follo	wing.					
			Disadvantage against bending stress	Advantage against bending stress					
		Mounting	Perforation or slit	Perforation or slit					
		face	Break P.C.board with mounted side up.	Break P.C.board with mounted side down.					
		Chip arrangement (Direction)	Mount perpendicularly to perforation or slit Perforation or slit	Mount in parallel with perforation or slit Perforation or slit					
		Distance from slit	Closer to slit is higher stress $l_1$ $l_1$ $(\ell_1 < \ell_2)$	Away from slit is less stress $ \begin{array}{c}                                     $					







No.	Process			Condition				
4	Mounting	<ul> <li>capacitors to resu</li> <li>1) Adjust the botton surface and not</li> <li>2) Adjust the moun</li> <li>3) To minimize the</li> </ul>	ead is adjus It in cracking m dead cent press it. ating head p impact energe bottom side	ted too low, it may in g. Please take followin eer of the mounting he ressure to be 1 to 3N	ead to reach on the P.C.board			
			-	ecommended	Recommended			
		Single sided mounting		Crack	Support pin			
		Double-sides mounting	Solder	Crack	Support pin			
		When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.						
		4-2. Amount of adhe	esive					
					· <b>↓</b>			
			Example : 0	C2012 (CC0805), C32	216 (CC1206)			
		-	а	0.2mm mi	in.			
		-	b	70 - 100µ	m			
		-	С	Do not touch the s	solder land			



	Process		C	ondition		
5	Soldering	5-1. Flux selection Although highly-activat activity may also degra degradation, it is recon	ade the insulation	n of the chip ca	•	
		1) It is recommended to Strong flux is not reco	o use a mildly ad ommended.	ctivated rosin f	lux (less than 0	.1wt% chlorine)
		<ul><li>2) Excessive flux must t</li><li>3) When water-soluble f</li></ul>				ux.
		5-2. Recommended sold	ering profile by v	arious method		
		Wave sold Solde	ring			Idering
		Preheating → ←	Natural cooling	→ ←	Preheating >	← Natural cooling
		Peak Temp . (C) . C) . C) . C) . C) . C)		Peak Temp (C) dema 0 0		
		over 60 sec. →	np time		r 60 sec. → Peak	←→ Temp time
		Manual s (Solde	-	APPL	CATION	
		300 (C) C) C) C) C) C) C) C) C) C)		and C solder As for C1005 (CC18 reflow	C1608 (CC0603), 0 3216 (CC1206), ap ing and reflow solde C0402 (CC01005), 5 (CC0402), C3225 312), C5750 (CC222 soldering.	plied to wave ering. C0603 (CC0201), (CC1210), C4532
			_  <	<u> </u>		
		5-3. Recommended sold	ering peak temp	and peak tem	o duration	
		Temp./Duration	Wave so	ldering	Reflow so	oldering
		Solder	Peak temp(°C)	Duration(sec.)	Peak temp(°C)	Duration(sec.)
		Sn-Pb Solder	250 max.	3 max.	230 max.	20 max.
		Lead Free Solder	260 max.	5 max.	260 max.	10 max.
		Recommended solde Sn-37Pb (Sn-Pb sol Sn-3.0Ag-0.5Cu (Le	lder)			



	Process			Condi	ition			
5	Soldering	5-4. Avo	5-4. Avoiding thermal shock					
		1) Preh	eating condition					
		,	Soldering		Туре	Т	emp. (°C)	
			Wave soldering	C1608(CC0603),		5)	∆T ≤ 150	
			wave soldering	C3216(CC1206)			<u>A</u> 1 <u>=</u> 100	
				C0402(CC01005				
				C1005(CC0402),	•		∆T ≤ 150	
			Reflow soldering	C2012(CC0805),	•			
				C3225(CC1210), C5750(CC2220)	C4552(CC1612	<u>,</u>	∆T ≤ 130	
				C0402(CC01005	) C0603(CC020 <sup>2</sup>	1)		
				C1005(CC0402),			∆T ≤ 150	
			Manual soldering	C2012(CC0805),				
				C3225(CC1210), C5750(CC2220)	C4532(CC1812	2),	∆T ≤ 130	
			emperature change	king. In sufficient solder m Higher tensile force in chip capacitors to cause				
			etach the capacitor cessive	rs from the P.C.bo			ile force in	
		Exc solo	cessive /	rs from the P.C.bo		chip capaci	ile force in tors to cause	
		Exc solo Ade	cessive /	rs from the P.C.bo		chip capaci crack <u>num amount</u> <u>num amount</u> _ow robustr cause conta	ile force in tors to cause	
		Exc sold Add Inst sold 5-6. Sold 1) Sele Tip land hea Ple time chip	cessive der	r iron ng iron tip der iron varies by the tip temperature e a crack in the ch tip temp. before s th following recom the condition in 5-4	its type, P.C.bc e, the quicker ti ip capacitors. soldering and k mended condi to avoid the th	chip capacit crack num amount num amount Low robustr cause conta chip capacit the P.C.boa bard materi he operatio eep the pea tion. (Pleas ermal shoc	ile force in tors to cause	
		Exc sold Add Inst sold 5-6. Sold 1) Sele Tip land hea Ple time chip	cessive der	r iron ng iron tip der iron varies by the tip temperature e a crack in the ch tip temp. before s th following recom the condition in 5-4	its type, P.C.bc e, the quicker ti ip capacitors. soldering and k mended condi to avoid the th	chip capacit crack num amount num amount Low robustr cause conta chip capacit the P.C.boa bard materi he operation eep the pea tion. (Pleas ermal shoc	ile force in tors to cause	





No.	Process	Condition
5	Soldering	<ol> <li>Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron.</li> </ol>
		5-7. Sn-Zn solder
		Sn-Zn solder affects product reliability.
		Please contact TDK in advance when utilize Sn-Zn solder.
		5-8. Countermeasure for tombstone
		The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especiall the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering.
		(Refer to JEITA RCR-2335B Annex 1 (Informative) Recommendations to prevent tombstone phenomenon)
6	Cleaning	1) If an unsuitable cleaning fluid is used, flux residue or some foreign articles may
		stick to chip capacitors surface to deteriorate especially the insulation resistance
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing
		(1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned
		problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output
		can affect the connection between the ceramic chip capacitor's body and the
		terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/ & max.
		Frequency : 40 kHz max.
		Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may
		bring the same result as insufficient cleaning.



No.	Process		Condition					
7	Coating and	1) When the	P.C.board is coated, please verify the	he quality influence on the product.				
	molding of the P.C.board	<ul> <li>2) Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.</li> <li>3) Please verify the curing temperature.</li> </ul>						
		3) Please verify the curing temperature.						
8	Handling after chip mounted	<ol> <li>Please pay attention not to bend or distort the P.C.board after soldering in otherwise the chip capacitors may crack.</li> </ol>						
	▲ Caution	to be adj and bend	Twist Twist					
		Item	Not recommended	Recommended				
		Board bending	Termination peeling Check pin	Support pin				
9	Handling of loose chip capacitors	the large handle wi 2) Piling the		ency to have cracks easily, so please				



No.	Process	Condition
10	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient : 3 multiplication rule, Temperature acceleration coefficient : 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.
12	Others ⚠ Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		<ul> <li>(1) Aerospace/Aviation equipment</li> <li>(2) Transportation equipment (cars, electric trains, ships, etc.)</li> <li>(3) Medical equipment</li> <li>(4) Power-generation control equipment</li> <li>(5) Atomic energy-related equipment</li> <li>(6) Seabed equipment</li> <li>(7) Transportation control equipment</li> <li>(8) Public information-processing equipment</li> <li>(9) Military equipment</li> <li>(10) Electric heating apparatus, burning equipment</li> <li>(11) Disaster prevention/crime prevention equipment</li> <li>(12) Safety equipment</li> <li>(13) Other applications that are not considered general-purpose applications</li> </ul>
		When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.



### 13. Packaging label

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

1) Inspection No.
 2) TDK P/N
 3) Customer's P/N
 4) Quantity

\*Composition of Inspection No.

Example  $\underline{M} \underline{2} \underline{A} - \underline{OO} - \underline{OOO}$ (a) (b) (c) (d) (e)

a) Line code

b) Last digit of the year

c) Month and A for January and B for February and so on. (Skip I)

d) Inspection Date of the month.

e) Serial No. of the day

### 14. Bulk packaging quantity

Total number of components in a plastic bag for bulk packaging: 1,000pcs. As for C0402, C0603 and C1005 types, not available for bulk packaging.



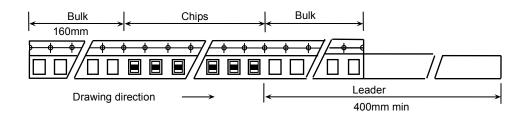
### **15. TAPE PACKAGING SPECIFICATION**

#### **1. CONSTRUCTION AND DIMENSION OF TAPING**

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4. Dimensions of plastic tape shall be according to Appendix 5, 6.

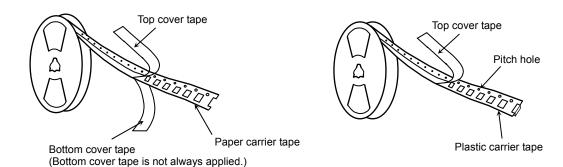
1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 7, 8. Dimensions of Ø330 reel shall be according to Appendix 9, 10.

1-4. Structure of taping





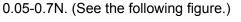
### 2. CHIP QUANTITY

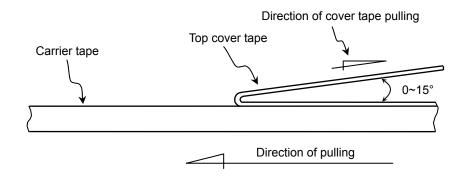
Tuno	Thickness	Taping	Chip quantity (pcs.)			
Туре	of chip	Material	φ178mm reel	φ330mm reel		
C0402	0.20 mm	Paper	20,000	-		
C0603	C0603 0.30 mm Paper		15,000	-		
C1005	0.50 mm	Paper	10,000	50,000		
C1608	0.80 mm	Paper	4,000	10,000		
	0.60 mm	Paper	4 000			
C2012	0.85 mm	Paper or Plastic	4,000	10,000		
	1.25 mm	Plastic	2,000			
	0.60 mm	Paper	4 000			
	0.85 mm	Paper or Plastic	4,000	10.000		
C3216	1.15 mm			- 10,000		
	1.30 mm	Plastic	2,000			
	1.60 mm			8,000		
	1.15 mm		2,000	10,000		
	1.25 mm		2,000			
	1.30 mm			8,000		
C3225	1.60 mm	Plastic				
	2.00 mm			5,000		
	2.30 mm		1,000			
	2.50 mm					
	1.60 mm		1,000	- 3,000		
	2.00 mm		1,000			
C4532	2.30 mm	Plastic				
04002	2.50 mm	Flastic	500			
	2.80 mm		500	2 000		
	3.20 mm			2,000		
	2.00 mm					
C5750	2.30 mm	Plastic	500	3,000		
03730	2.50 mm		500			
	2.80 mm			2,000		



### 3. PERFORMANCE SPECIFICATIONS

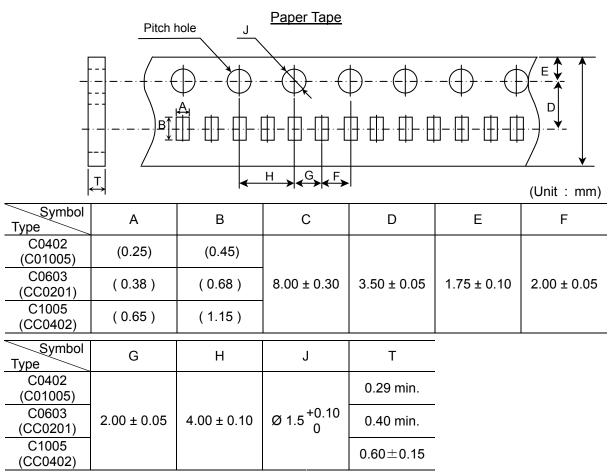
3-1. Fixing peeling strength (top tape)





- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.

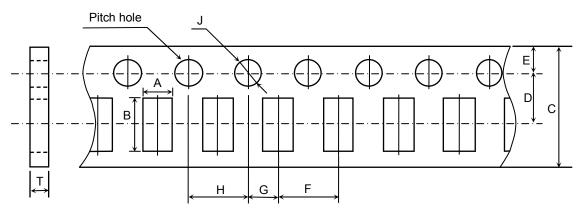




\* The values in the parentheses ( ) are for reference.



Paper Tape



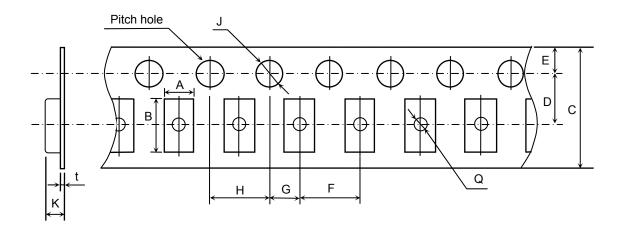
(Unit : mm)

Symbol Type	А	В	С	D	E	F
C1608 (CC0603)	(1.10)	(1.90)				
C2012 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3216 (CC1206)	(1.90)	(3.50)				
Symbol Type	G	Н	J	Т		
C1608 (CC0603)						
C2012 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10 0	1.10 max.		
C3216 (CC1206)						

\* The values in the parentheses ( ) are for reference.



Plastic Tape



(Unit : mm)

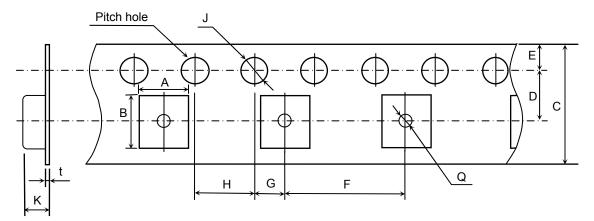
Symbol Type	А	В	С	D	E	F
C2012 (CC0805)	(1.50)	(2.30)	8.00 1.0.20	2 50 1 0 05		
C3216 (CC1206)	(1.90)	(3.50)	8.00 ± 0.30	3.50 ± 0.05 [5.50 ± 0.05]	1.75 ± 0.10	4.00 ± 0.10
C3225 (CC1210)	(2.90)	(3.60)	[12:0 ± 0:00]	[0.00 ± 0.00]		
Symbol Type	G	Н	J	К	t	Q
C2012 (CC0805)				2.50 max.	0.30 max.	
C3216 (CC1206)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10 0	2.50 max.	0.50 max.	Ø 0.50 min.
C3225 (CC1210)				3.20 max.	0.60 max.	

\* The values in the parentheses ( ) are for reference.

\* As for 2.5mm thickness products, apply values in the brackets [ ].



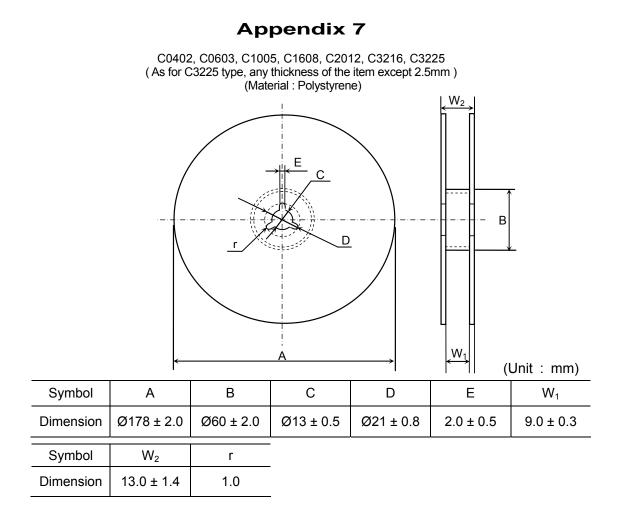
Plastic Tape



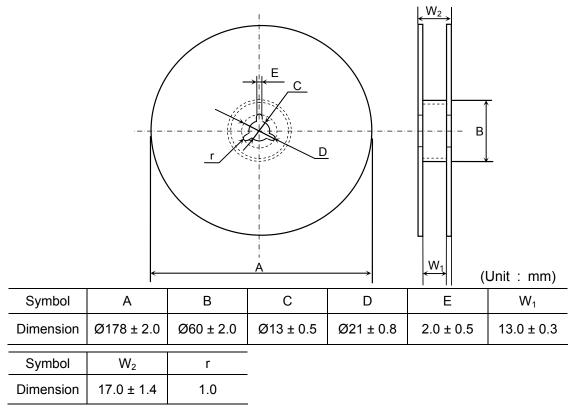
(Unit : mm) Symbol А В С D Е F Туре C4532 (3.60) (4.90) (CC1812)  $12.0\pm0.30$  $5.50 \pm 0.05$  $1.75 \pm 0.10$  $8.00 \pm 0.10$ C5750 (5.40) (6.10) (CC2220) Symbol G Н J Κ t Q Туре C4532 Ø 1.5 +0.10 0 (CC1812)  $2.00 \pm 0.05$  $4.00 \pm 0.10$ 6.50 max. 0.60 max. Ø 1.50 min. C5750 (CC2220)

\* The values in the parentheses ( ) are for reference.

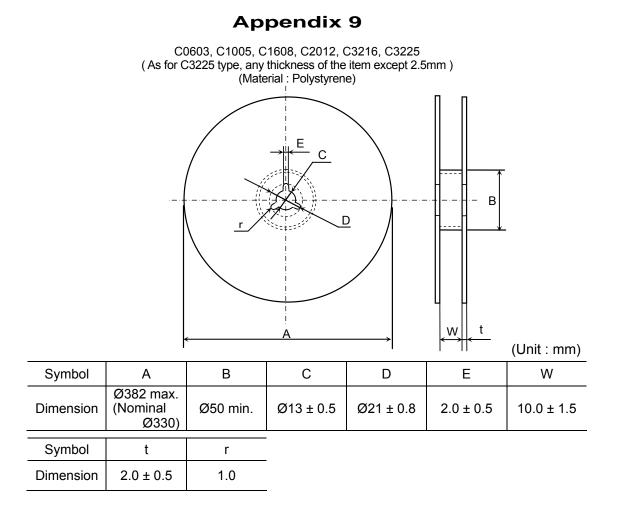




C3225, C4532, C5750 (As for C3225 type, applied to 2.5mm thickness products ) (Material : Polystyrene)







C3225, C4532, C5750 (As for C3225 type, applied to 2.5mm thickness products ) (Material : Polystyrene)

					B	(Unit : mm)
Symbol	А	В	С	D	Е	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5
Symbol	t	r				
Dimension	2.0 ± 0.5	1.0	-			

